

# MCR12DSM, MCR12DSN

Preferred Device

## Sensitive Gate Silicon Controlled Rectifiers

### Reverse Blocking Thyristors

Designed for high volume, low cost, industrial and consumer applications such as motor control; process control; temperature, light and speed control.

#### Features

- Small Size
- Passivated Die for Reliability and Uniformity
- Low Level Triggering and Holding Characteristics
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V  
Machine Model, C > 400 V
- Pb-Free Packages are Available

#### MAXIMUM RATINGS ( $T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1) ( $T_J = -40$ to $110^\circ\text{C}$ , Sine Wave, 50 to 60 Hz, Gate Open) MCR12DSM MCR12DSN	$V_{DRM}$ , $V_{RRM}$	600 800	V
On-State RMS Current ( $180^\circ$ Conduction Angles; $T_C = 75^\circ\text{C}$ )	$I_{T(RMS)}$	12	A
Average On-State Current ( $180^\circ$ Conduction Angles; $T_C = 75^\circ\text{C}$ )	$I_{T(AV)}$	7.6	A
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, $T_J = 110^\circ\text{C}$ )	$I_{TSM}$	100	A
Circuit Fusing Consideration ( $t = 8.3$ msec)	$I^2t$	41	$\text{A}^2\text{sec}$
Forward Peak Gate Power (Pulse Width $\leq 1.0$ $\mu\text{sec}$ , $T_C = 75^\circ\text{C}$ )	$P_{GM}$	5.0	W
Forward Average Gate Power ( $t = 8.3$ msec, $T_C = 75^\circ\text{C}$ )	$P_{G(AV)}$	0.5	W
Forward Peak Gate Current (Pulse Width $\leq 1.0$ $\mu\text{sec}$ , $T_C = 75^\circ\text{C}$ )	$I_{GM}$	2.0	A
Operating Junction Temperature Range	$T_J$	-40 to 110	$^\circ\text{C}$
Storage Temperature Range	$T_{stg}$	-40 to 150	$^\circ\text{C}$

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1.  $V_{DRM}$  and  $V_{RRM}$  for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the device are exceeded.



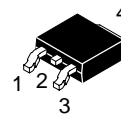
ON Semiconductor®

<http://onsemi.com>

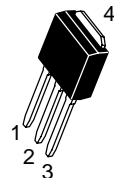
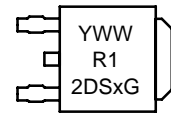
SCRs  
12 AMPERES RMS  
600 – 800 VOLTS



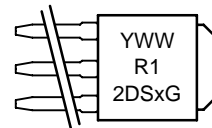
#### MARKING DIAGRAMS



DPAK  
CASE 369C  
STYLE 4



DPAK-3  
CASE 369D  
STYLE 4



Y = Year  
WW = Work Week  
R12DSx = Device Code  
x = M or N  
G = Pb-Free Package

#### PIN ASSIGNMENT

Pin	Assignment
1	Cathode
2	Anode
3	Gate
4	Anode

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

# MCR12DSM, MCR12DSN

## THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, – Junction–to–Case	$R_{\theta JC}$	2.2	$^{\circ}C/W$
– Junction–to–Ambient	$R_{\theta JA}$	88	
– Junction–to–Ambient (Note 2)	$R_{\theta JA}$	80	
Maximum Lead Temperature for Soldering Purposes (Note 3)	$T_L$	260	$^{\circ}C$

## ELECTRICAL CHARACTERISTICS ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristics	Symbol	Min	Typ	Max	Unit
-----------------	--------	-----	-----	-----	------

## OFF CHARACTERISTICS

Peak Repetitive Forward or Reverse Blocking Current (Note 4) ( $V_{AK} = \text{Rated } V_{DRM}$ or $V_{RRM}$ ; $R_{GK} = 1.0 \text{ K}\Omega$ )	$I_{DRM}$ , $I_{RRM}$	–	–	10	$\mu A$
$T_J = 25^{\circ}C$		–	–	500	
$T_J = 110^{\circ}C$		–	–		

## ON CHARACTERISTICS

Peak Reverse Gate Blocking Voltage, ( $I_{GR} = 10 \mu A$ )	$V_{GRM}$	10	12.5	18	V
Peak Reverse Gate Blocking Current, ( $V_{GR} = 10 \text{ V}$ )	$I_{GRM}$	–	–	1.2	$\mu A$
Peak Forward On–State Voltage (Note 5), ( $I_{TM} = 20 \text{ A}$ )	$V_{TM}$	–	1.3	1.9	V
Gate Trigger Current (Continuous dc) (Note 6) ( $V_D = 12 \text{ V}$ , $R_L = 100 \Omega$ )	$I_{GT}$	5.0	12	200	$\mu A$
$T_J = 25^{\circ}C$		–	–	300	
$T_J = -40^{\circ}C$					
Gate Trigger Voltage (Continuous dc) (Note 6) ( $V_D = 12 \text{ V}$ , $R_L = 100 \Omega$ )	$V_{GT}$	0.45	0.65	1.0	V
$T_J = 25^{\circ}C$		–	–	1.5	
$T_J = -40^{\circ}C$		0.2	–	–	
$T_J = 110^{\circ}C$					
Holding Current ( $V_D = 12 \text{ V}$ , Initiating Current = 200 mA, Gate Open)	$I_H$	0.5	1.0	6.0	mA
$T_J = 25^{\circ}C$		–	–	10	
$T_J = -40^{\circ}C$					
Latching Current ( $V_D = 12 \text{ V}$ , $I_G = 2.0 \text{ mA}$ )	$I_L$	0.5	1.0	6.0	mA
$T_J = 25^{\circ}C$		–	–	10	
$T_J = -40^{\circ}C$					
Turn–On Time (Source Voltage = 12 V, $R_S = 6.0 \text{ K}\Omega$ , $I_T = 16 \text{ A(pk)}$ , $R_{GK} = 1.0 \text{ K}\Omega$ ) ( $V_D = \text{Rated } V_{DRM}$ , Rise Time = 20 ns, Pulse Width = 10 $\mu s$ )	tgt	–	2.0	5.0	$\mu s$

## DYNAMIC CHARACTERISTICS

Critical Rate of Rise of Off–State Voltage ( $V_D = 0.67 \times \text{Rated } V_{DRM}$ , Exponential Waveform, $R_{GK} = 1.0 \text{ K}\Omega$ , $T_J = 110^{\circ}C$ )	dv/dt	2.0	10	–	V/ $\mu s$
---	-------	-----	----	---	------------

- These ratings are applicable when surface mounted on the minimum pad sizes recommended.
- 1/8" from case for 10 seconds.
- Ratings apply for negative gate voltage or  $R_{GK} = 1.0 \text{ k}\Omega$ . Devices shall not have a positive gate voltage concurrently with a negative voltage on the anode. Devices should not be tested with a constant current source for forward and reverse blocking capability such that the voltage applied exceeds the rated blocking voltage.
- Pulse Test: Pulse Width  $\leq 2.0 \text{ msec}$ , Duty Cycle  $\leq 2\%$ .
- $R_{GK}$  current not included in measurement.

# MCR12DSM, MCR12DSN

## Voltage Current Characteristic of SCR

Symbol	Parameter
$V_{DRM}$	Peak Repetitive Off State Forward Voltage
$I_{DRM}$	Peak Forward Blocking Current
$V_{RRM}$	Peak Repetitive Off State Reverse Voltage
$I_{RRM}$	Peak Reverse Blocking Current
$V_{TM}$	Peak On State Voltage
$I_H$	Holding Current

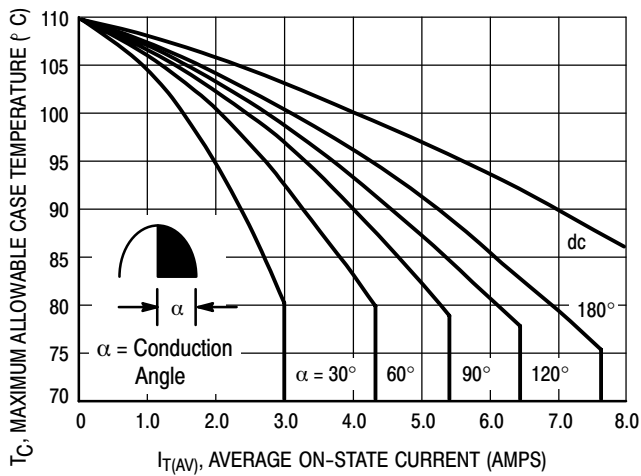
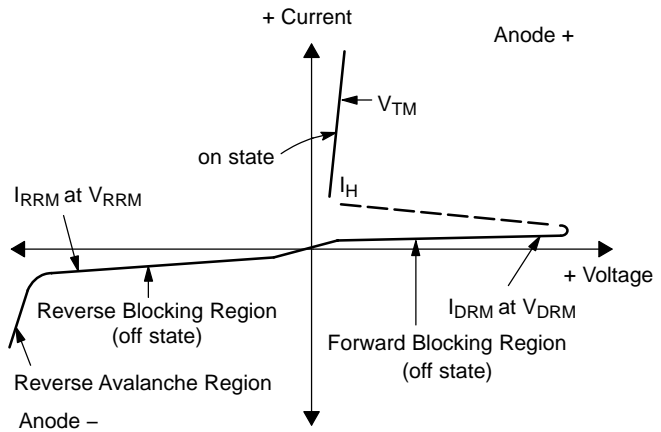


Figure 1. Average Current Derating

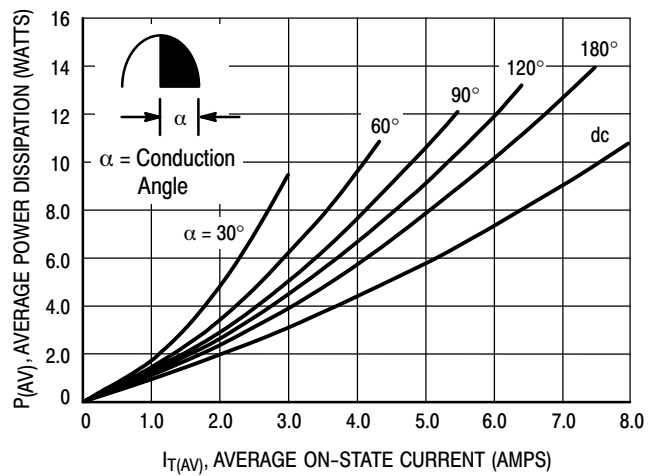


Figure 2. On-State Power Dissipation

# MCR12DSM, MCR12DSN

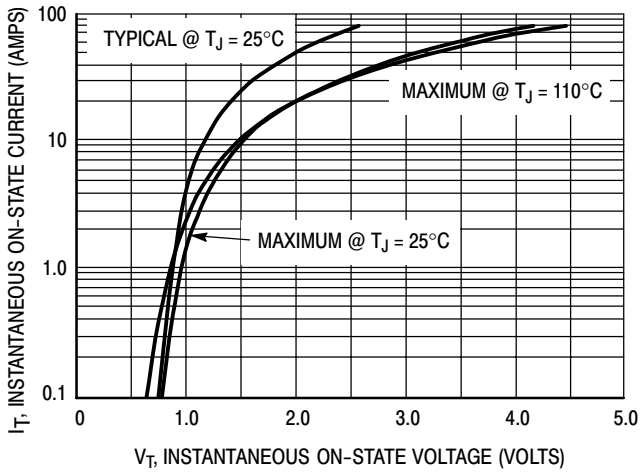


Figure 3. On-State Characteristics

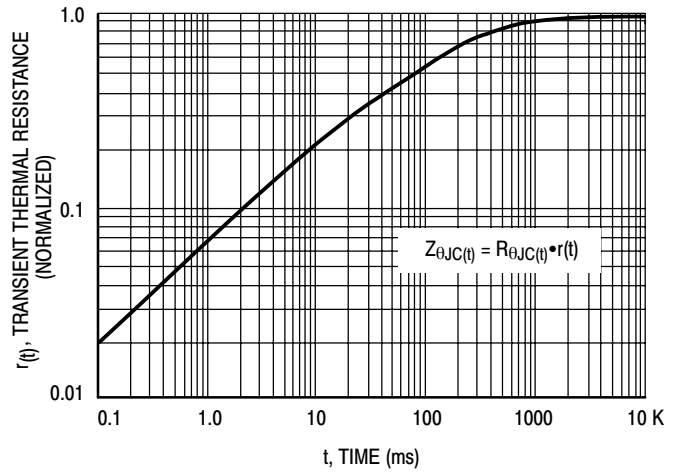


Figure 4. Transient Thermal Response

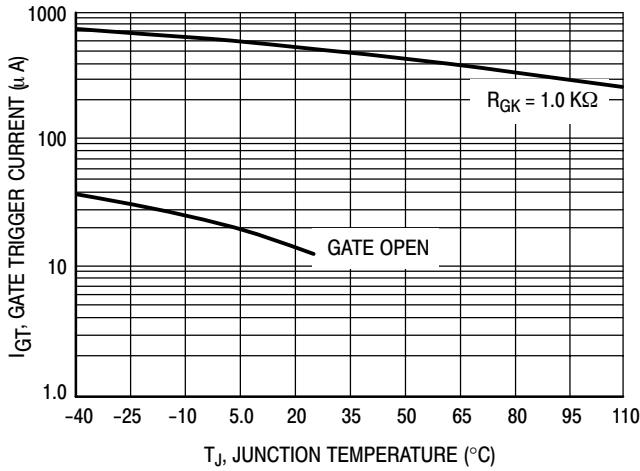


Figure 5. Typical Gate Trigger Current versus Junction Temperature

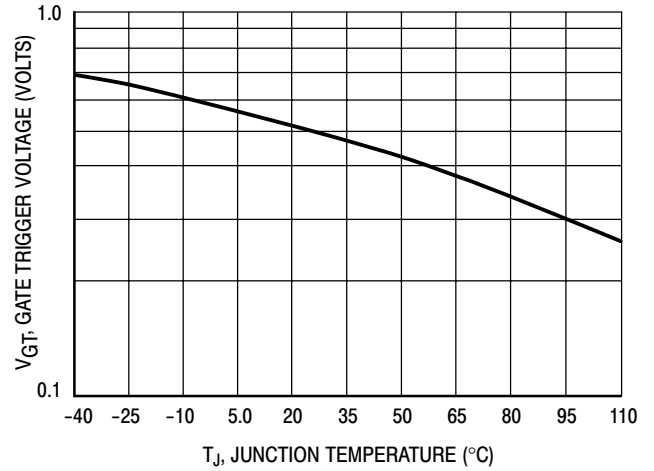


Figure 6. Typical Gate Trigger Voltage versus Junction Temperature

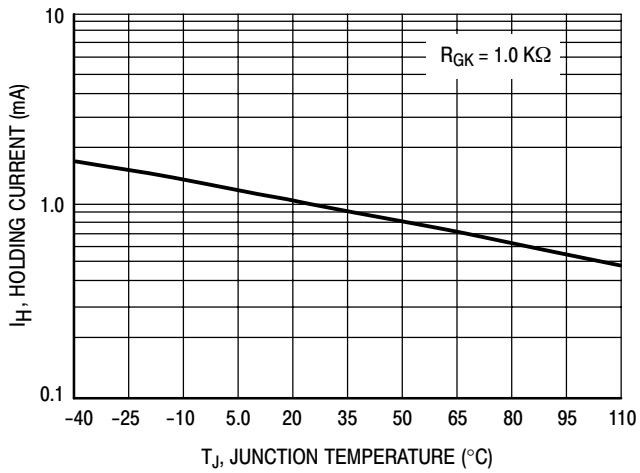


Figure 7. Typical Holding Current versus Junction Temperature

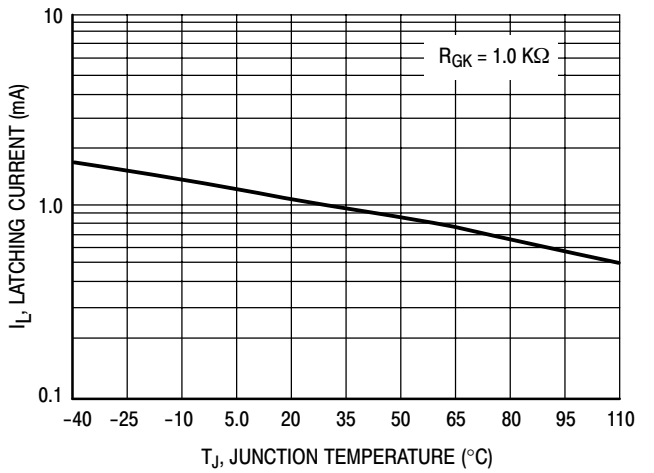
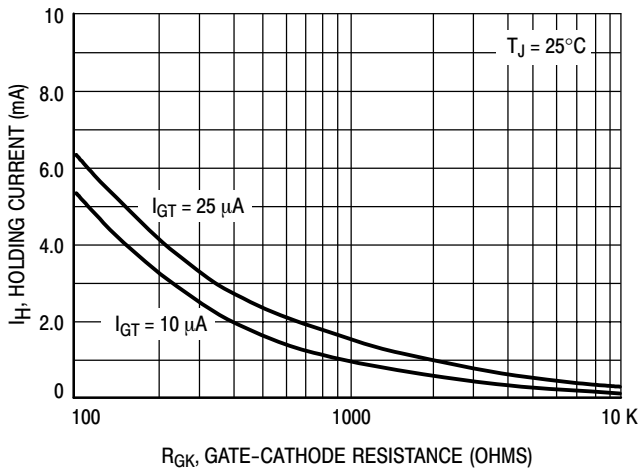
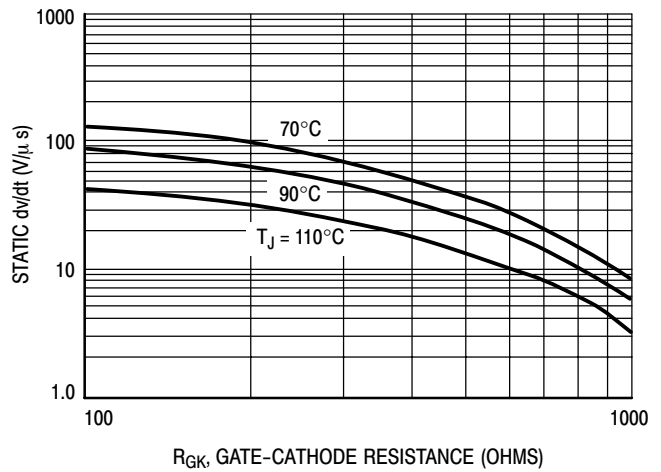


Figure 8. Typical Latching Current versus Junction Temperature

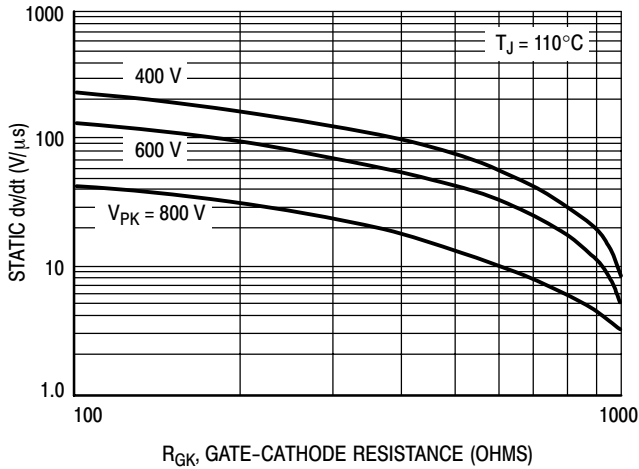
# MCR12DSM, MCR12DSN



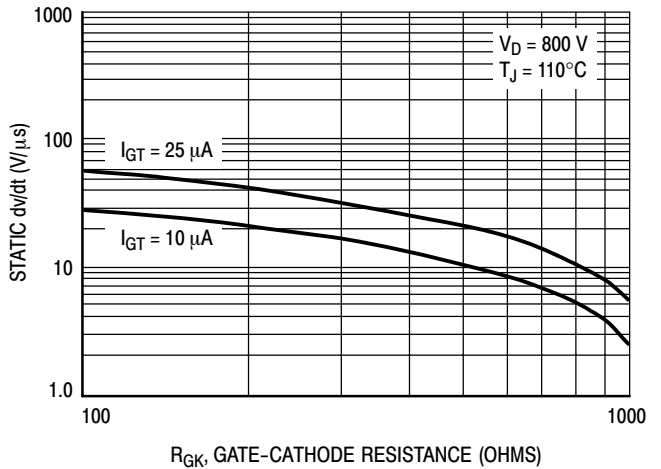
**Figure 9. Holding Current versus Gate-Cathode Resistance**



**Figure 10. Exponential Static dv/dt versus Gate-Cathode Resistance and Junction Temperature**



**Figure 11. Exponential Static dv/dt versus Gate-Cathode Resistance and Peak Voltage**



**Figure 12. Exponential Static dv/dt versus Gate-Cathode Resistance and Gate Trigger Current Sensitivity**

## ORDERING INFORMATION

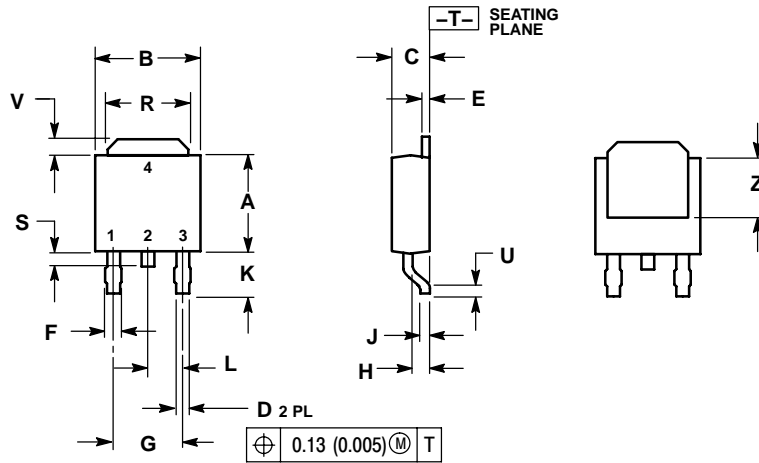
Device	Package Type	Package	Shipping†
MCR12DSMT4	DPAK	369C	2500 / Tape & Reel
MCR12DSMT4G	DPAK (Pb-Free)	369C	2500 / Tape & Reel
MCR12DSN-001	DPAK-3	369D	75 Units / Rail
MCR12DSN-001G	DPAK-3 (Pb-Free)	369D	75 Units / Rail
MCR12DSNT4	DPAK	369C	2500 / Tape & Reel
MCR12DSNT4G	DPAK (Pb-Free)	369C	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# MCR12DSM, MCR12DSN

## PACKAGE DIMENSIONS

DPAK  
CASE 369C  
ISSUE O

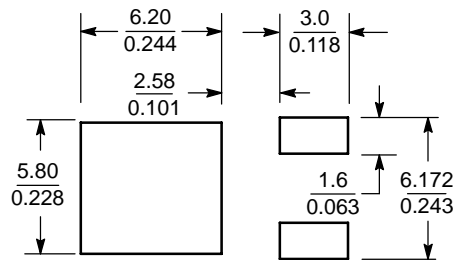


- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.22
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180 BSC		4.58 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020	---	0.51	---
V	0.035	0.050	0.89	1.27
Z	0.155	---	3.93	---

- STYLE 4:  
PIN 1. CATHODE  
2. ANODE  
3. GATE  
4. ANODE

### SOLDERING FOOTPRINT\*



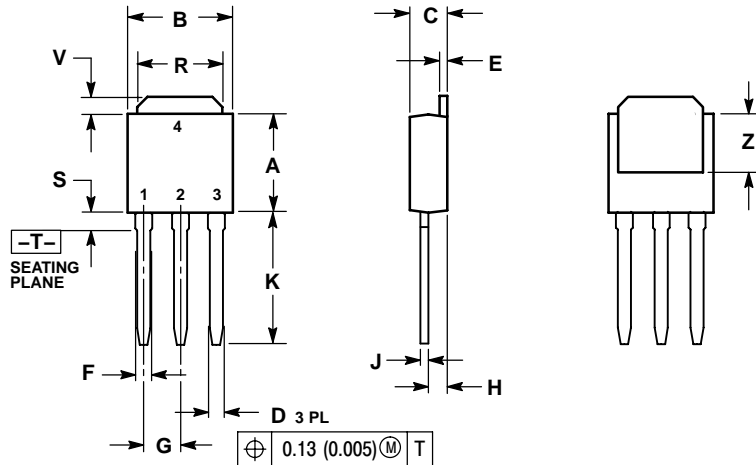
SCALE 3:1  $\left(\frac{\text{mm}}{\text{inches}}\right)$

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# MCR12DSM, MCR12DSN

## PACKAGE DIMENSIONS

DKPAK-3  
CASE 369D-01  
ISSUE B



**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.235	0.245	5.97	6.35
B	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
H	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155	---	3.93	---

**STYLE 4:**

- PIN 1: CATHODE
- 2: ANODE
- 3: GATE
- 4: ANODE

ON Semiconductor and are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

**PUBLICATION ORDERING INFORMATION**

**LITERATURE FULFILLMENT:**  
Literature Distribution Center for ON Semiconductor  
P.O. Box 61312, Phoenix, Arizona 85082-1312 USA  
**Phone:** 480-829-7710 or 800-344-3860 Toll Free USA/Canada  
**Fax:** 480-829-7709 or 800-344-3867 Toll Free USA/Canada  
**Email:** orderlit@onsemi.com

**N. American Technical Support:** 800-282-9855 Toll Free USA/Canada

**Japan:** ON Semiconductor, Japan Customer Focus Center  
2-9-1 Kamimeguro, Meguro-ku, Tokyo, Japan 153-0051  
**Phone:** 81-3-5773-3850

**ON Semiconductor Website:** <http://onsemi.com>

**Order Literature:** <http://www.onsemi.com/litorder>

For additional information, please contact your local Sales Representative.